Application/Control No.	Applicant(s)/Patent under Reexamination
09/895,173	HOSHINO, SATOSHI
Examiner	Art Unit

2624

Shefali D. Patel

	SEARCHED				
Class	Subclass	Date	Examiner		
382	100,115, 118,284	1/23/2007	SDP		
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INI	INTERFERENCE SEARCHED				
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
·		DATE	EXMR
EAST		1/23/2007	SDP
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